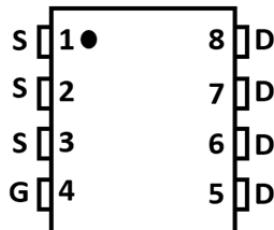
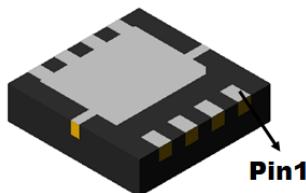
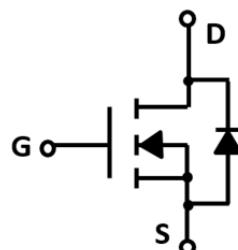


N-Channel Enhancement Mode Field Effect Transistor

**DFN333**

Product Summary

- V_{DS} 30 V
- I_D 60 A
- $R_{DS(ON)}$ (at $V_{GS}=10V$) <3.2 mohm
- $R_{DS(ON)}$ (at $V_{GS}=4.5V$) <4.0 mohm
- 100% UIS Tested
- 100% ∇V_{DS} Tested

General Description

- Trench Power LV MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low $R_{DS(ON)}$

Applications

- DC-DC Converters
- Power management functions
- Backlighting

Absolute Maximum Ratings ($T_A=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-source Voltage	V_{DS}	30	V
Gate-source Voltage	V_{GS}	± 20	V
Drain Current $T_c=25^\circ C$	I_D	60	A
$T_c=100^\circ C$		38	
Pulsed Drain Current ^A	I_{DM}	240	A
Total Power Dissipation @ $T_c=25^\circ C$ ^B	P_D	75	W
Total Power Dissipation @ $T_c=100^\circ C$ ^B	P_D	30	W
Total Power Dissipation @ $T_A=25^\circ C$ ^C	P_D	6.2	W
Single Pulse Avalanche Energy ^D	E_{AS}	400	mJ
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	1.67	$^\circ C/W$
Thermal Resistance Junction-to-Ambient	$R_{\theta JA}$	20	$^\circ C/W$
Junction and Storage Temperature Range	T_J, T_{STG}	-55~+150	$^\circ C$

Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
YJQ60N03A	F1	Q60N03A	5000	10000	100000	13" reel



YJQ60N03A

■ Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	30			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}}=30\text{V}, V_{\text{GS}}=0\text{V}$			1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{\text{GS}}= \pm 20\text{V}, V_{\text{DS}}=0\text{V}$			± 100	nA
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	1.0	1.5	2.5	V
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}= 10\text{V}, I_{\text{D}}=20\text{A}$		2.6	3.2	$\text{m}\Omega$
		$V_{\text{GS}}= 4.5\text{V}, I_{\text{D}}=20\text{A}$		3.4	4.0	
Diode Forward Voltage	V_{SD}	$I_{\text{S}}=20\text{A}, V_{\text{GS}}=0\text{V}$		0.85	1.2	V
Gate resistance	R_g	F=1 MHz, Open drain		2.9		Ω
Dynamic Parameters						
Input Capacitance	C_{iss}	$V_{\text{DS}}=15\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$		4498		pF
Output Capacitance	C_{oss}			800		
Reverse Transfer Capacitance	C_{rss}			643		
Switching Parameters						
Total Gate Charge	$Q_g(10\text{V})$	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=15\text{V}, I_{\text{D}}=20\text{A}$		92.7		nC
Total Gate Charge	$Q_g(4.5\text{V})$			46		
Gate-Source Charge	Q_{gs}			13.5		
Gate-Drain Charge	Q_{gd}			22.8		
Reverse Recovery Charge	Q_{rr}	$I_f=20\text{A}, di/dt=500\text{A/us}$		3.0		ns
Reverse Recovery Time	t_{rr}			15		
Turn-on Delay Time	$t_{\text{D(on)}}$	$V_{\text{GS}}=10\text{V}, V_{\text{DD}}=20\text{V}, I_{\text{D}}=4\text{A}, R_{\text{L}}=0.75\Omega, R_{\text{GEN}}=3\Omega$		11		ns
Turn-on Rise Time	t_r			80		
Turn-off Delay Time	$t_{\text{D(off)}}$			39		
Turn-off fall Time	t_f			92		

- A. Pulse Test: Pulse Width $\leq 300\text{us}$, Duty cycle $\leq 2\%$.
- B. The power dissipation P_D is based on $T_{\text{J(MAX)}}=150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- C. The value of R_{GJA} is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with $TA = 25^\circ\text{C}$.
- D. $T_J=25^\circ\text{C}$, $V_{\text{DD}}=20\text{V}$, $V_G=10\text{V}$, $L=2.0\text{mH}$, $I_{\text{AS}}=20\text{A}$.

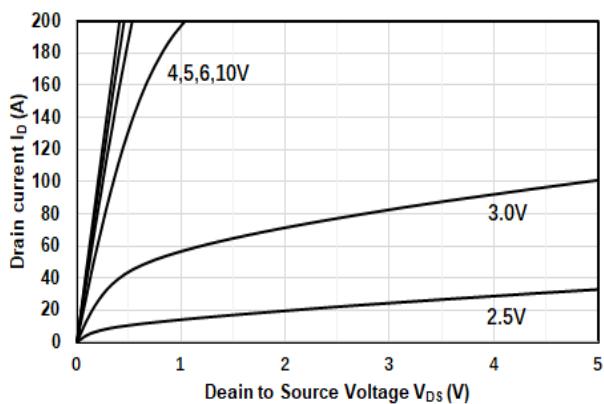
**■ Typical Performance Characteristics**

Figure1. Output Characteristics

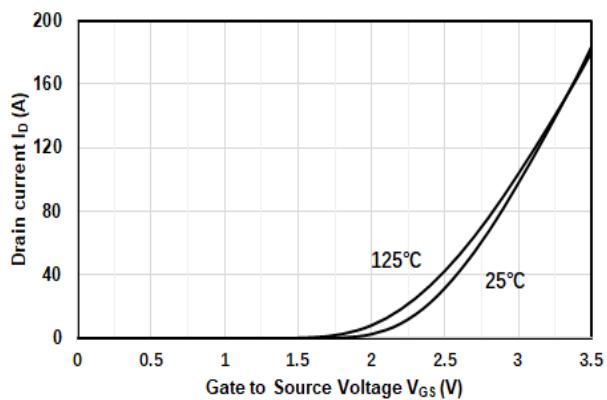


Figure2. Transfer Characteristics

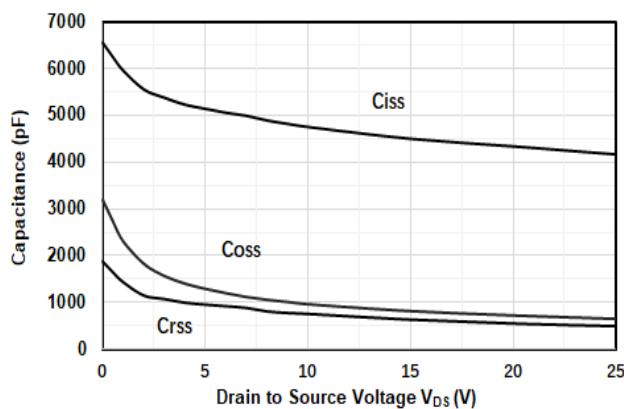


Figure3. Capacitance Characteristics

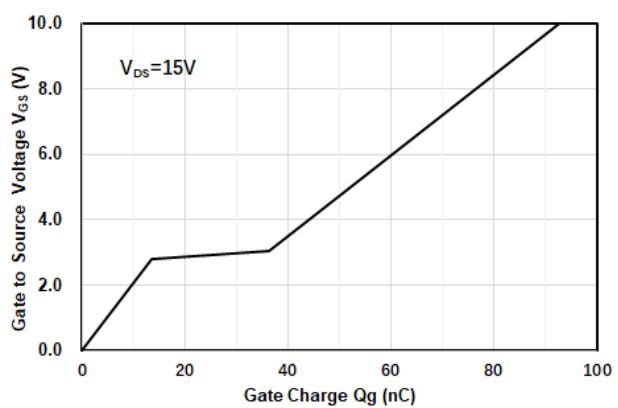


Figure4. Gate Charge

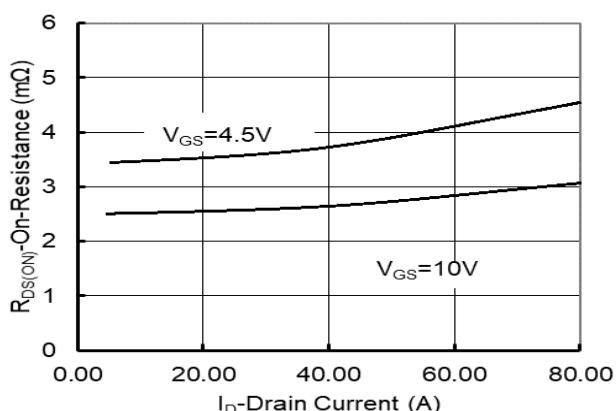


Figure5. Drain-Source on Resistance

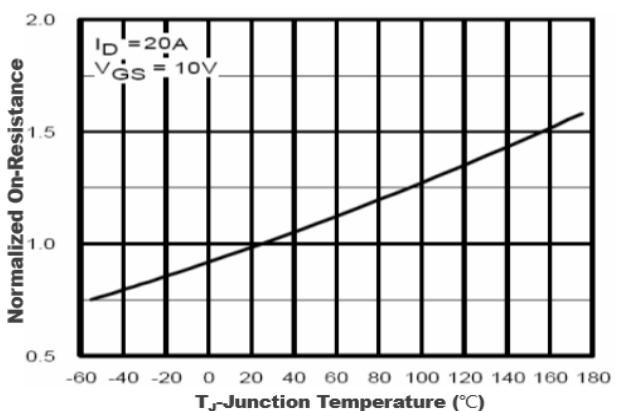


Figure6. Drain-Source on Resistance

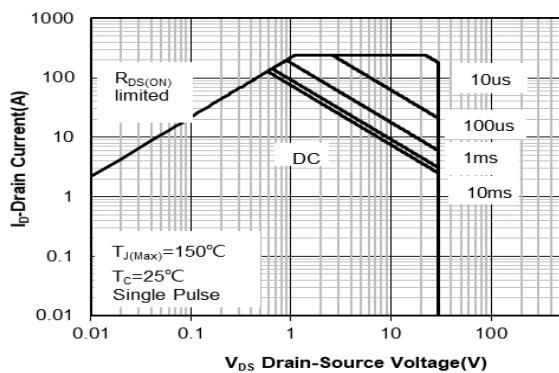


Figure7. Safe Operation Area

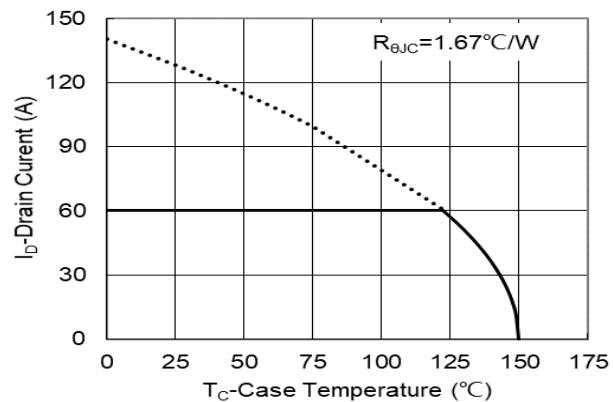


Figure8. Drain current vs. Case Temperature

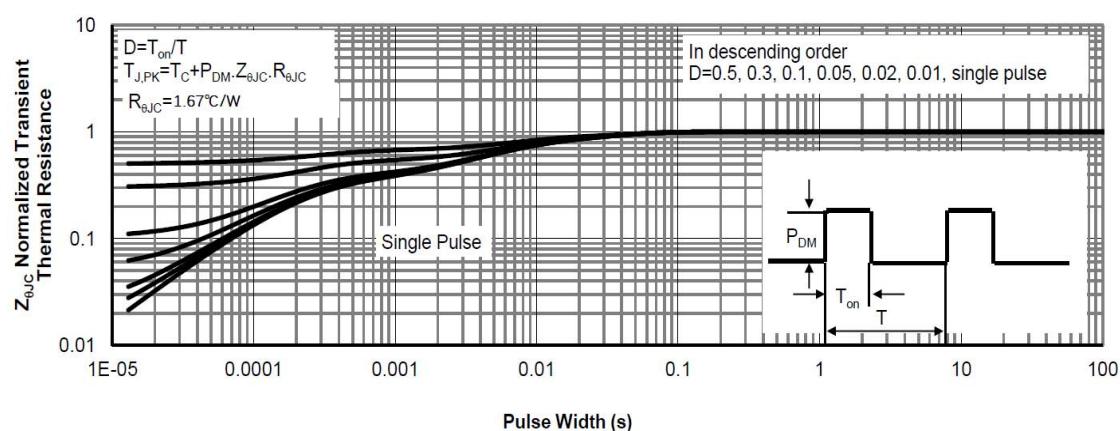
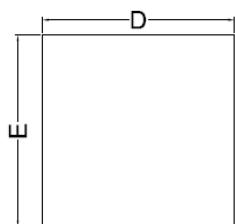
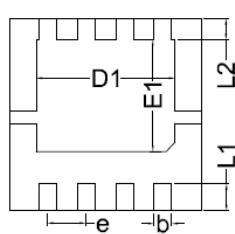
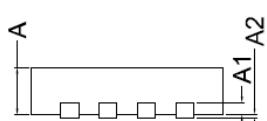


Figure9. Normalized Maximum Transient Thermal Impedance



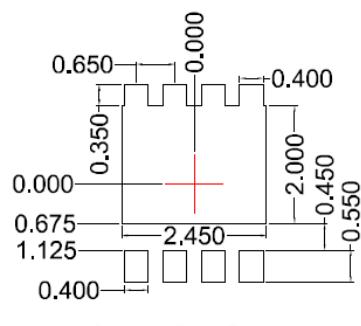
■ DFN3333 Package information

Top View
正面视图Bottom View
背面视图Side View
侧面视图

SYMBOL	MILLIMETER		
	MIN	NOM	MAX
D	3.15	3.25	3.35
E	3.15	3.25	3.35
A	0.70	0.80	0.90
A1		0.20 BSC	
A2			0.10
D1	2.20	2.35	2.50
E1	1.80	1.90	2.00
L1	0.35	0.45	0.55
L2		0.35 BSC	
b	0.20	0.30	0.40
e		0.65 BSC	

Note:

1. Controlling dimension:in millimeters.
2. General tolerance: $\pm 0.10\text{mm}$.
3. The pad layout is for reference purposes only.

Suggested Solder Pad Layout
Top View



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